

A fast avalanche photodiode for the readout of the fast 220nm component of barium fluoride scintillation light

DAVID HITLIN
CALTECH

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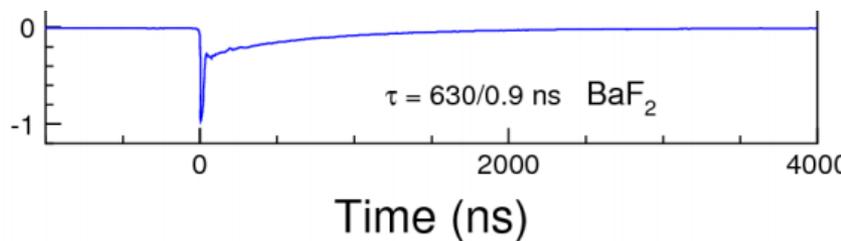
Outline

- ▶ Barium fluoride scintillation properties
- ▶ UV sensitive avalanche photodiode
- ▶ Adding an ALD filter to the APD
- ▶ Adding a superlattice
- ▶ Measurements
- ▶ Conclusion

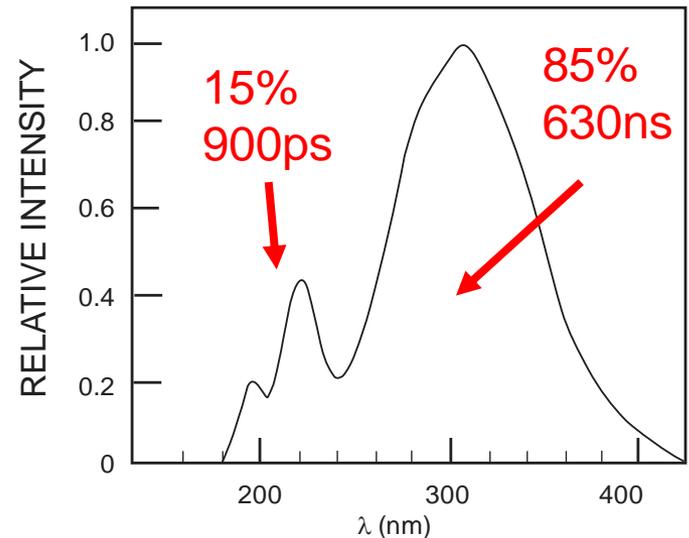


Barium fluoride scintillation light

- ▶ BaF₂ has a 220nm scintillation component with 900ps decay time, but also has a much larger 300nm component which has a 630ns decay time
- ▶ The fast component can provide excellent time resolution, for discrimination against background, as well as high rate capability
 - ▶ This requires either suppression of the emission of the slow component or use of a “solar blind” photosensor



Fast (cross-luminescence) 1,800 photons/MeV
Slow (self-trapped exciton) 10,000 photons/MeV



BaF₂ properties

Photosensor options

ALD filter

Superlattice

Gain, noise

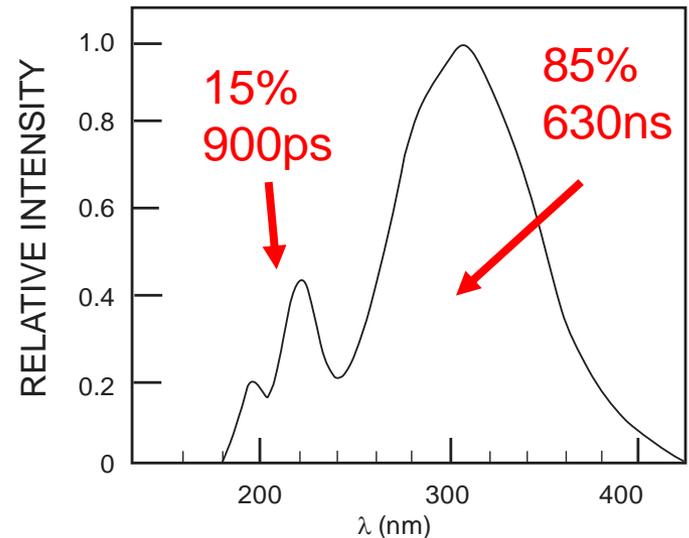
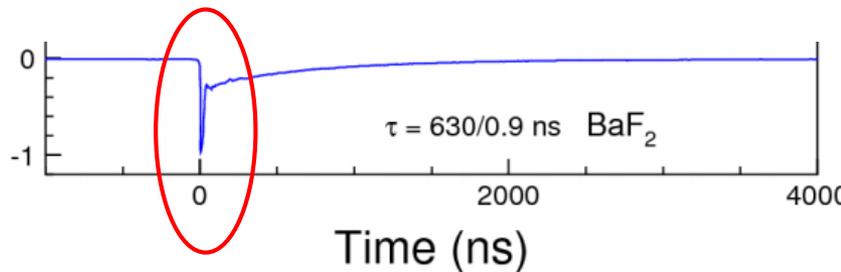
Radiation hardness

Conclusion



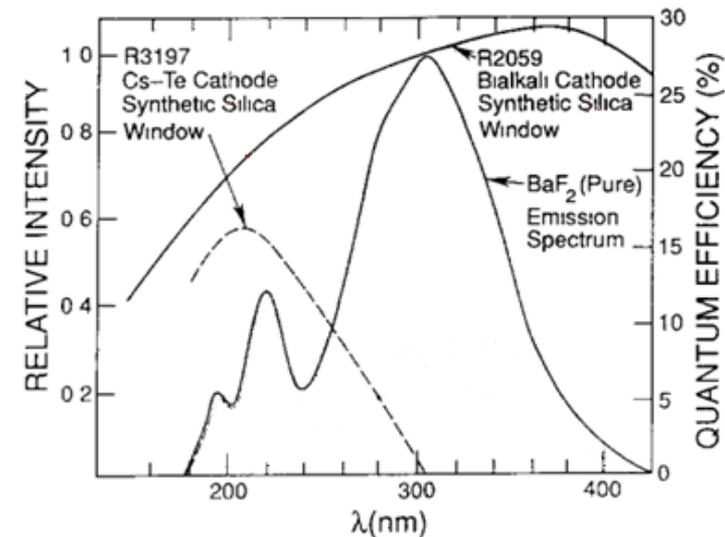
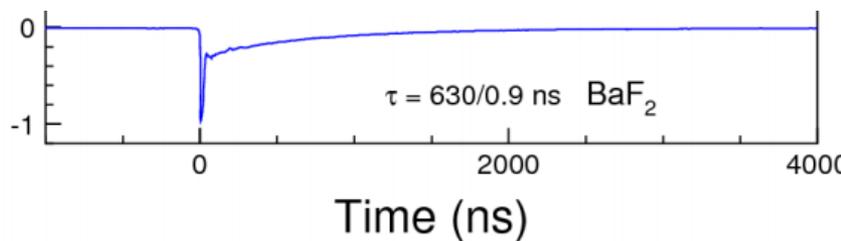
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BaF₂ properties

Photosensor options

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Superlattice

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Radiation hardness

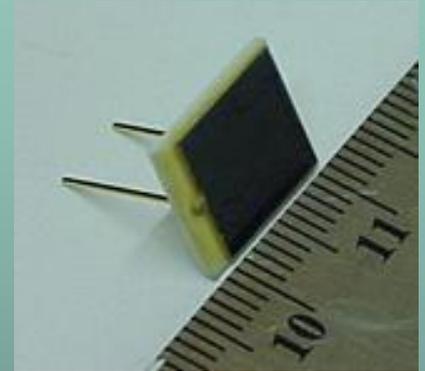
Conclusion



Photosensor R&D

Under a DOE SBIR Phase II grant, we* are developing an avalanche photodiode, based on an existing large area (9x9mm) RMD device, to produce a sensor that has

- High gain (500 @ ~1800V)
- High quantum efficiency at 220nm
- Suppression of response at 300nm
- Improved time response characteristics



The modifications consist of:

- Removal of undepleted silicon in front of avalanche region
- Using molecular beam epitaxy (MBE) to produce a superlattice region beneath the SiO_2 surface
- Producing an antireflection bandwidth filter using atomic layer deposition (ALD)

Work is also beginning on UV sensitive SiPMs

* K. Flood, D. G. Hitlin, J. H. Kim, J. Trevor, *Lauritsen Laboratory, Caltech*
M. Hoenk, J. Hennessey, A. Jewell, *Jet Propulsion Laboratory, Caltech*
R. Farrell, M. McClish, *RMD Inc.*

BaF₂
properties

Photosensor
options

ALD filter

Superlattice

Gain, noise

Radiation
hardness

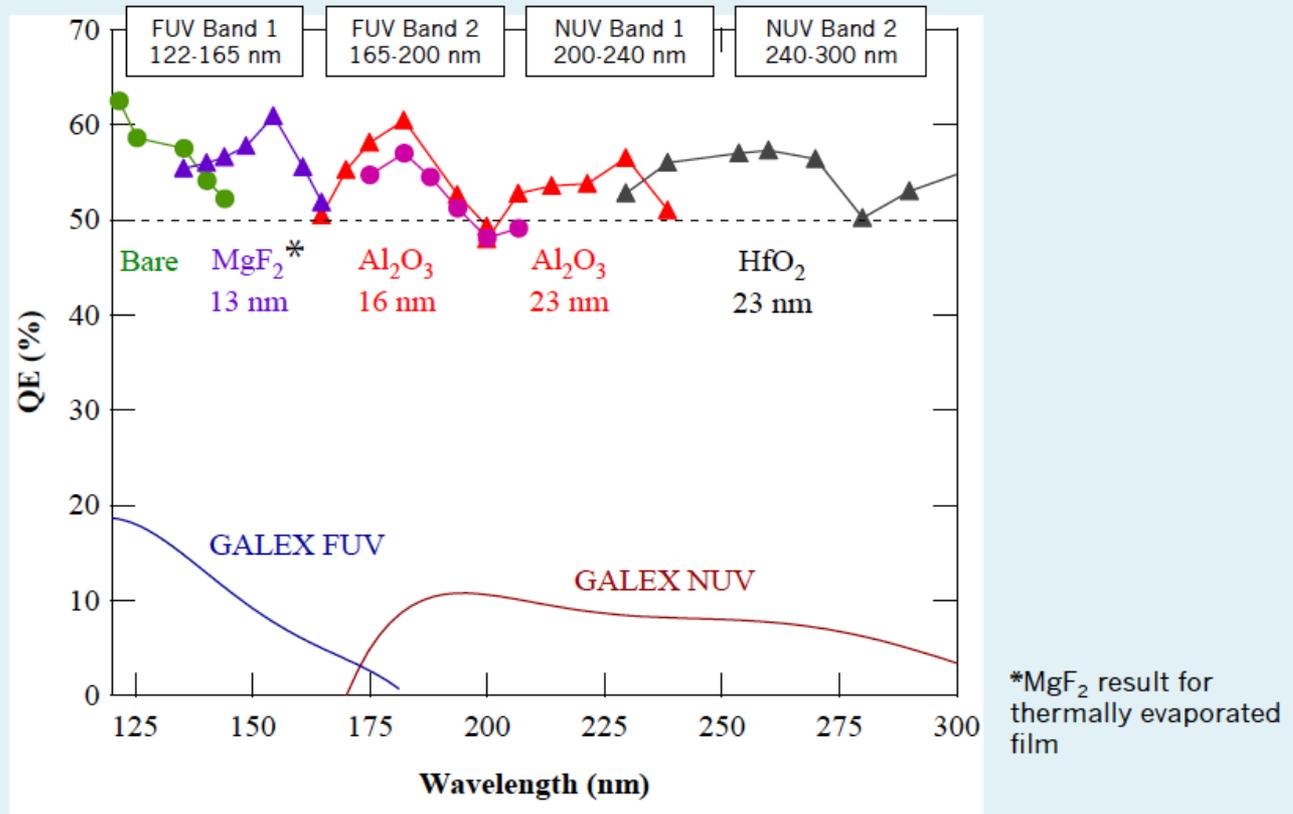
Conclusion



ALD antireflection filter



AR COATINGS FOR UV DETECTORS



ALD-AR coatings provide up to **2X improvement** over uncoated baseline and a **5x-50x improvement** over incumbent UV detector technology

BaF₂ properties

Photosensor options

ALD filter

Superlattice

Gain, noise

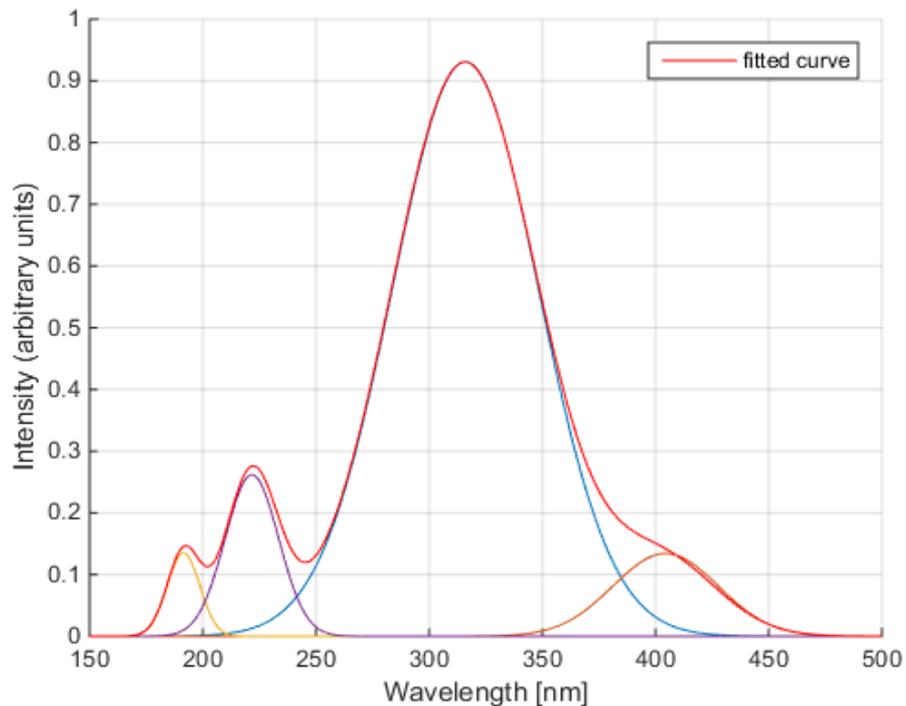
Radiation hardness

Conclusion



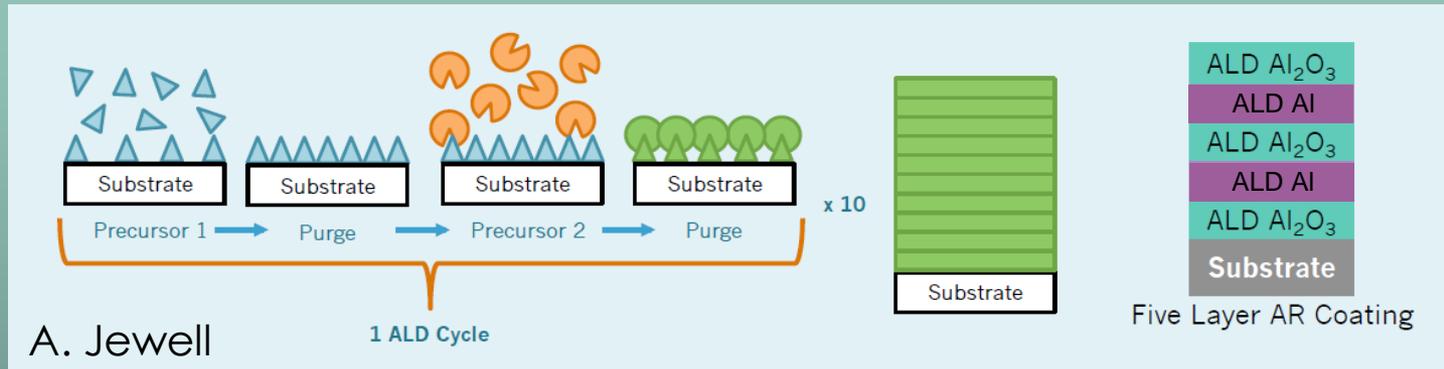
Bandpass filter

- ▶ The BaF₂ scintillation spectrum is well-fit by four Gaussians
- ▶ We have studied 3, 5 and 7 layer filters
The best choice is a five layer filter that encompasses the 195 nm and 220 nm fast decay time peaks and provides excellent suppression of the slow components

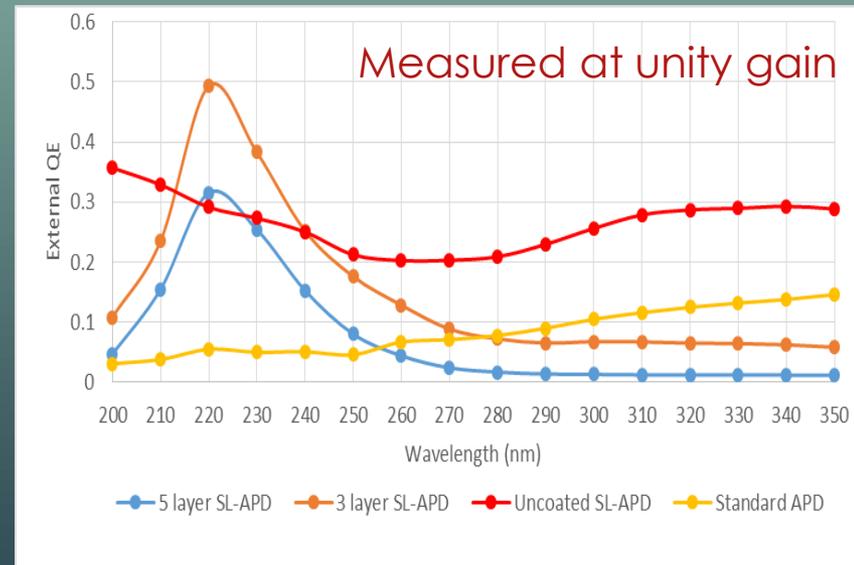


ALD antireflection filter

- Atomic layer deposition of multiple groups of single atomic layers produces integrated antireflection filters



- ALD filter has been designed to be efficient at 220 nm and provide strong extinction at 300 nm
- ALD filter characteristics can be adjusted to trade QE at 220nm for 300 nm extinction

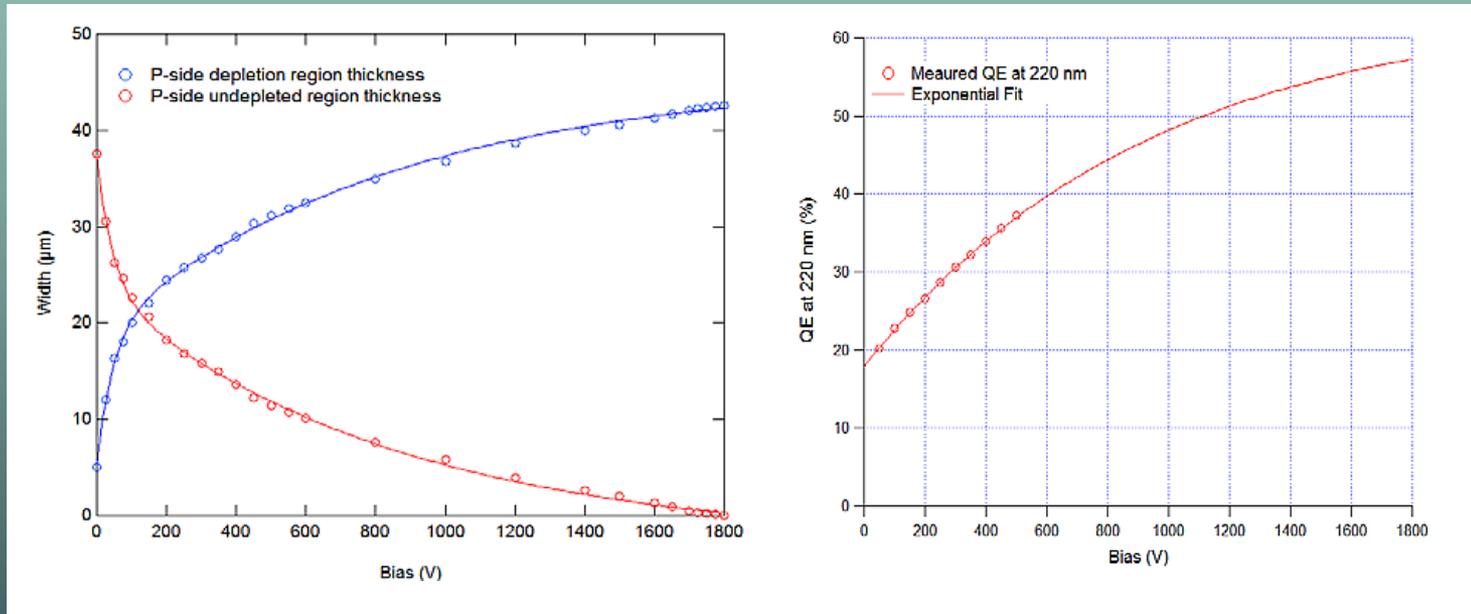


J. Hennessy



Effective QE increases with gain

- As full depletion is reached at high bias voltage, net quantum efficiency increases



BaF₂ properties

Photosensor options

ALD filter

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Bandpass filter

BaF₂
properties

Photosensor
options

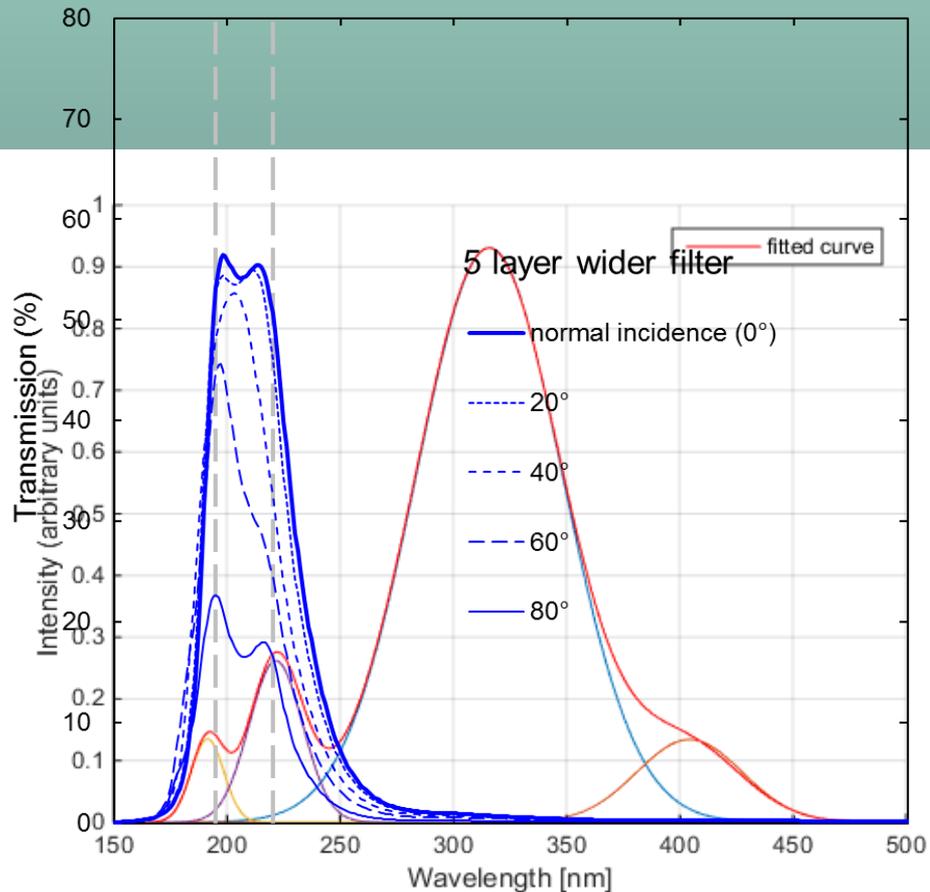
ALD filter

Superlattice

Gain, noise

Radiation
hardness

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Filter characteristics
vary with angle
of incidence



Net fast/slow component comparison

BaF₂ properties

Photosensor options

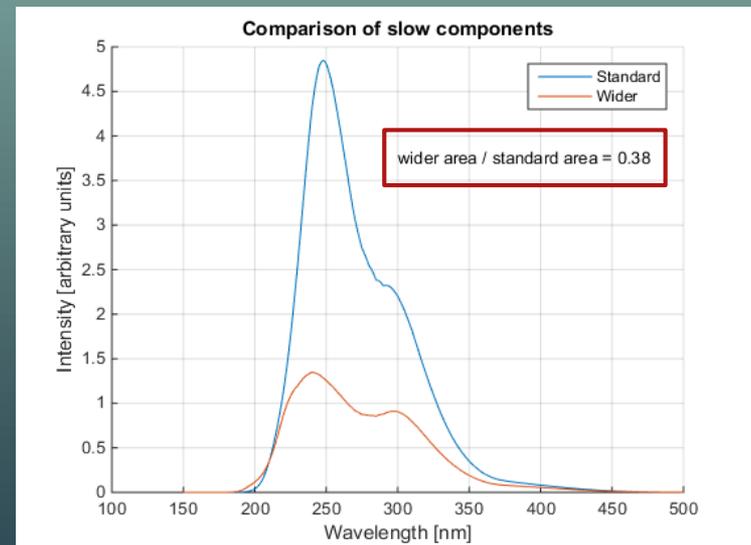
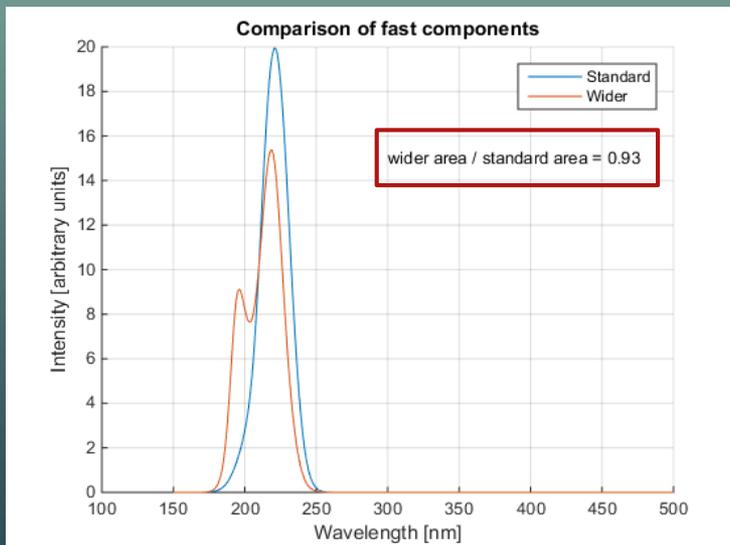
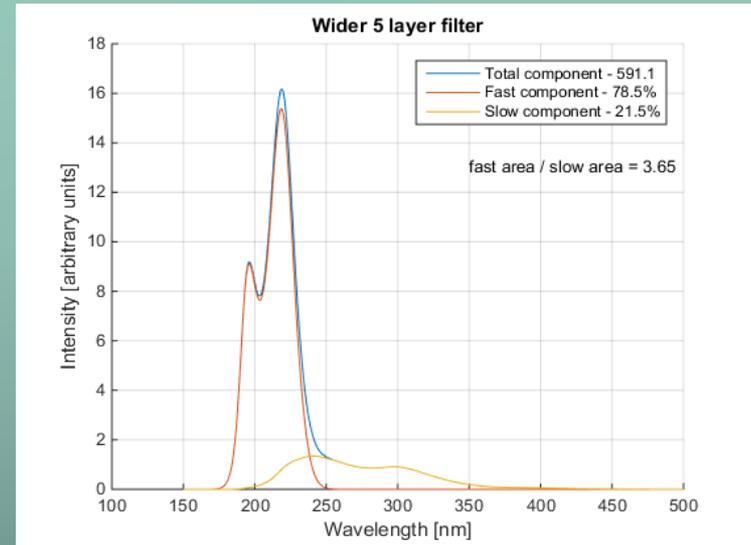
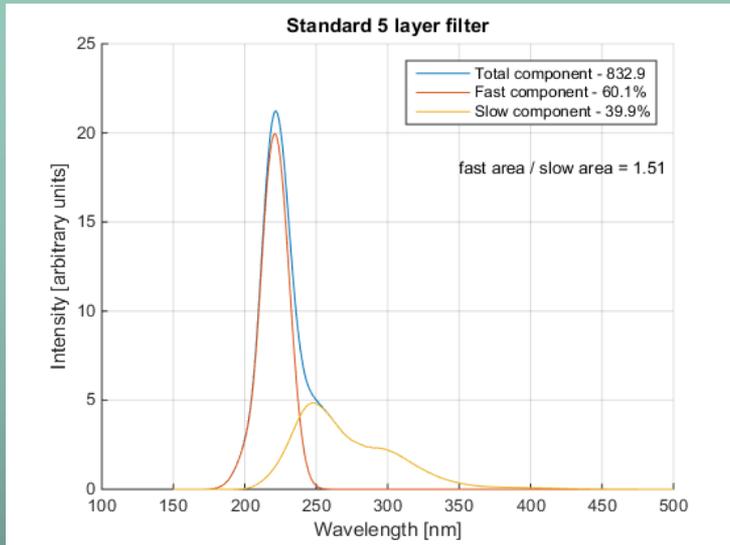
ALD filter

Superlattice

Gain, noise

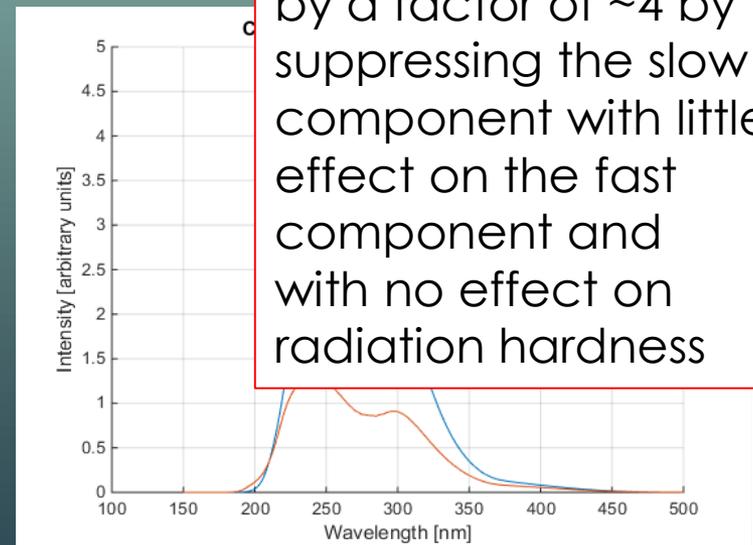
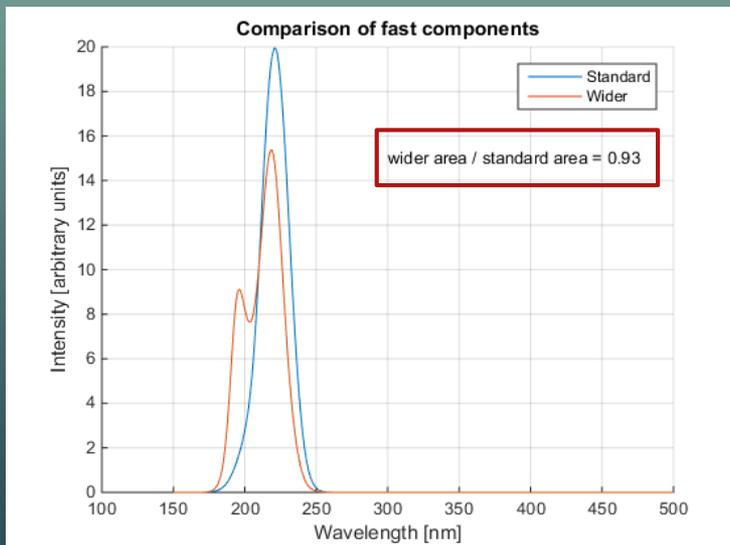
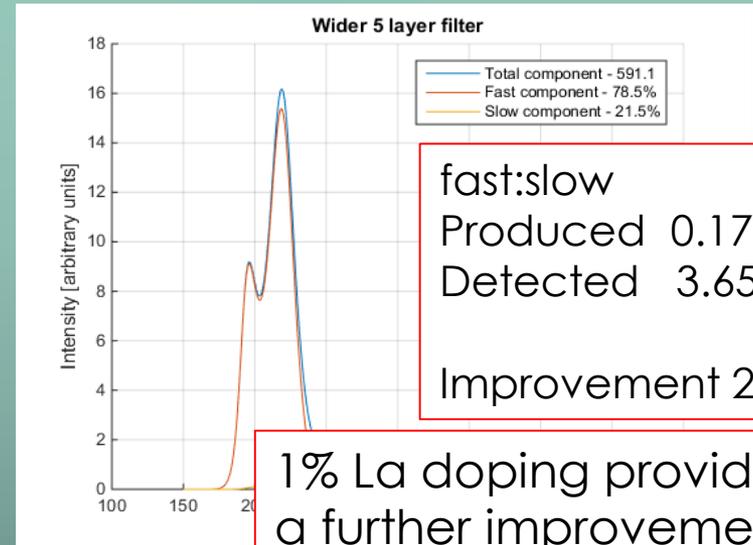
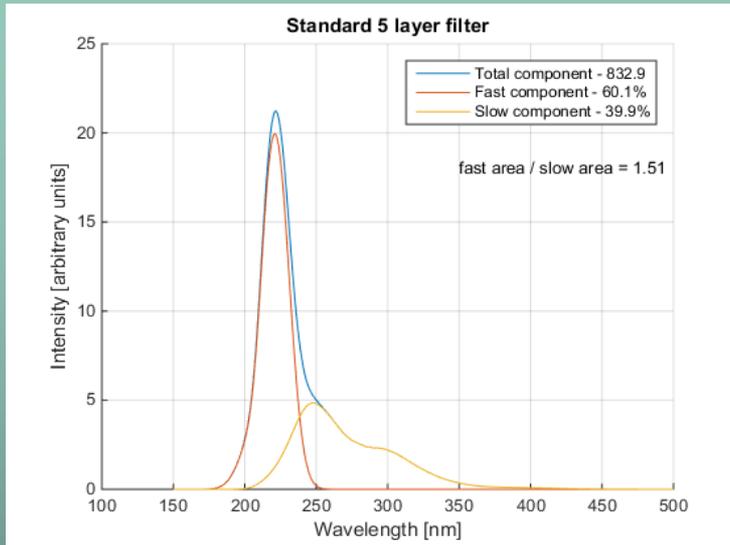
Radiation hardness

Conclusion



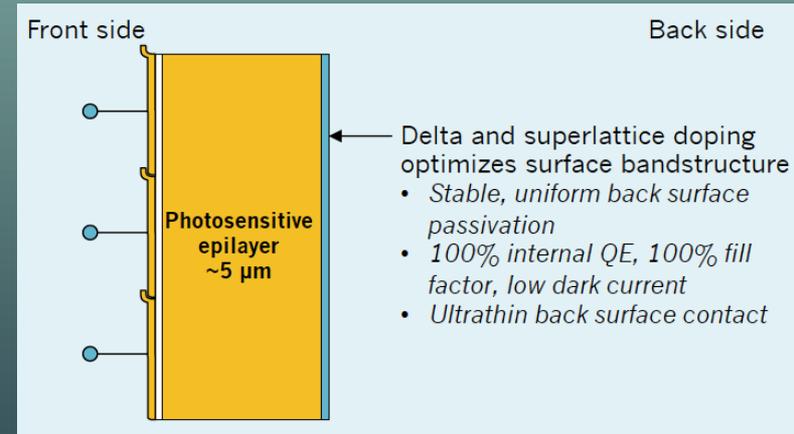
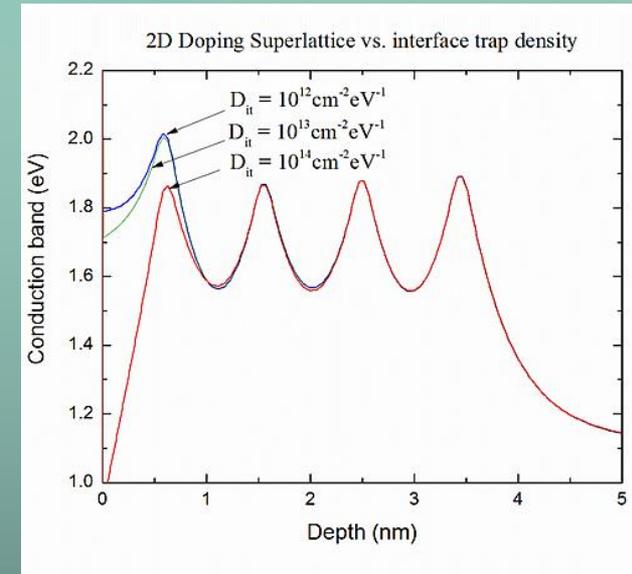
Net fast/slow component comparison

BaF₂ properties
Photosensor options
ALD filter
Superlattice
Gain, noise
Radiation hardness
Conclusion



Superlattice modifications

- JPL has developed superlattice structures that provide greatly enhanced quantum efficiency and improved time response
 - Delta-doping and superlattices have been successfully employed for many years to enhance the UV performance of CCDs and APDs used in UV astronomy in satellites and balloons
- Monoatomic layers of boron are implanted beneath the (thinned) photosensitive surface of the Si device using molecular beam epitaxy (MBE) (2D doping)
- The MBE layers allow the conduction band to remain stable with varying surface charge



M. Hoenk *et al.*, APL **61** 1084 (1992)

BaF₂ properties

Photosensor options

ALD filter

Superlattice

Gain, noise

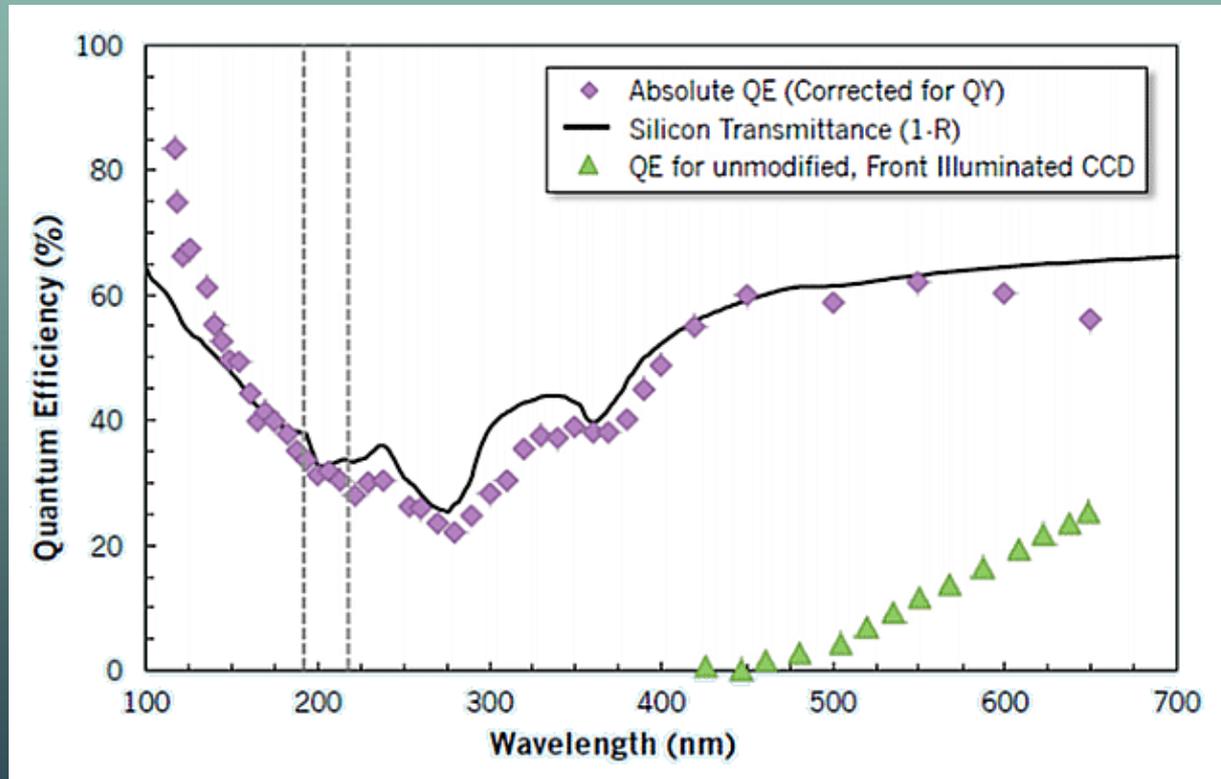
Radiation hardness

Conclusion



Superlattice modifications

- The superlattice suppresses recombination by quantum exclusion, producing close to 100% internal QE
- Quantum efficiency in the 200-300 nm region approaches Si transmittance limit



BaF₂ properties

Photosensor options

ALD filter

Superlattice

Gain, noise

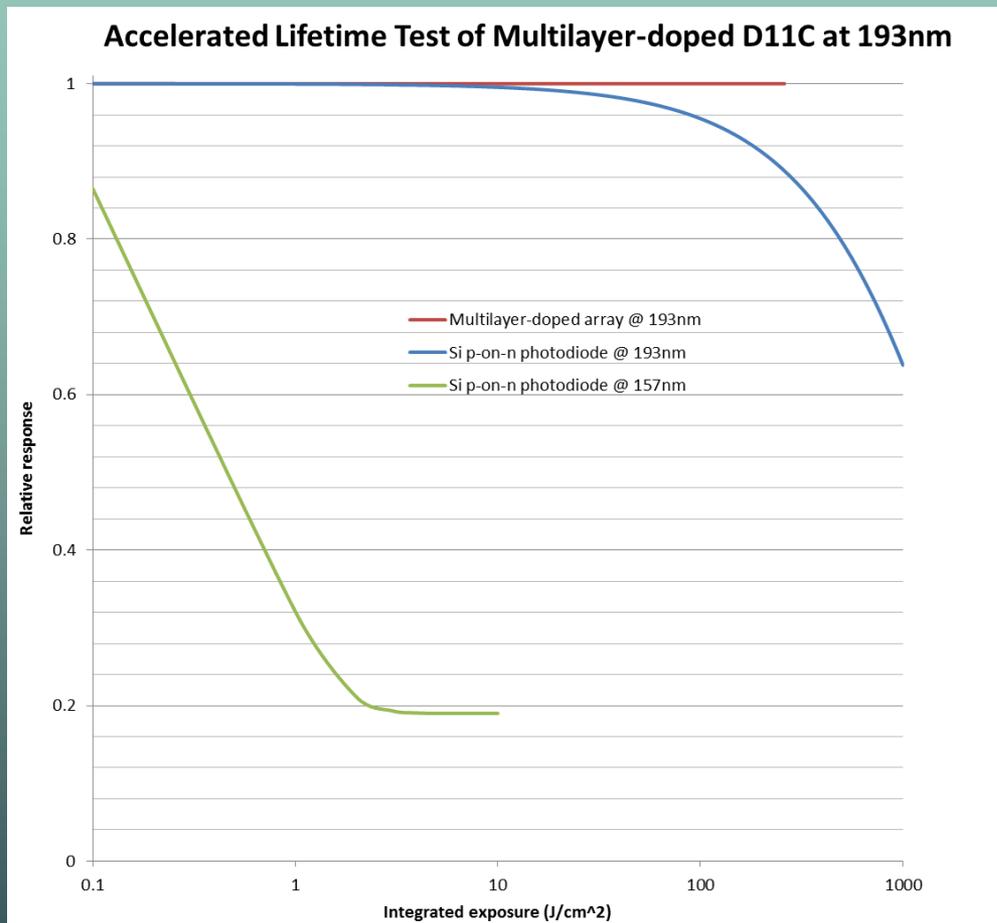
Radiation hardness

Conclusion



UV stability

- ▶ Superlattice provides stability under intense UV illumination

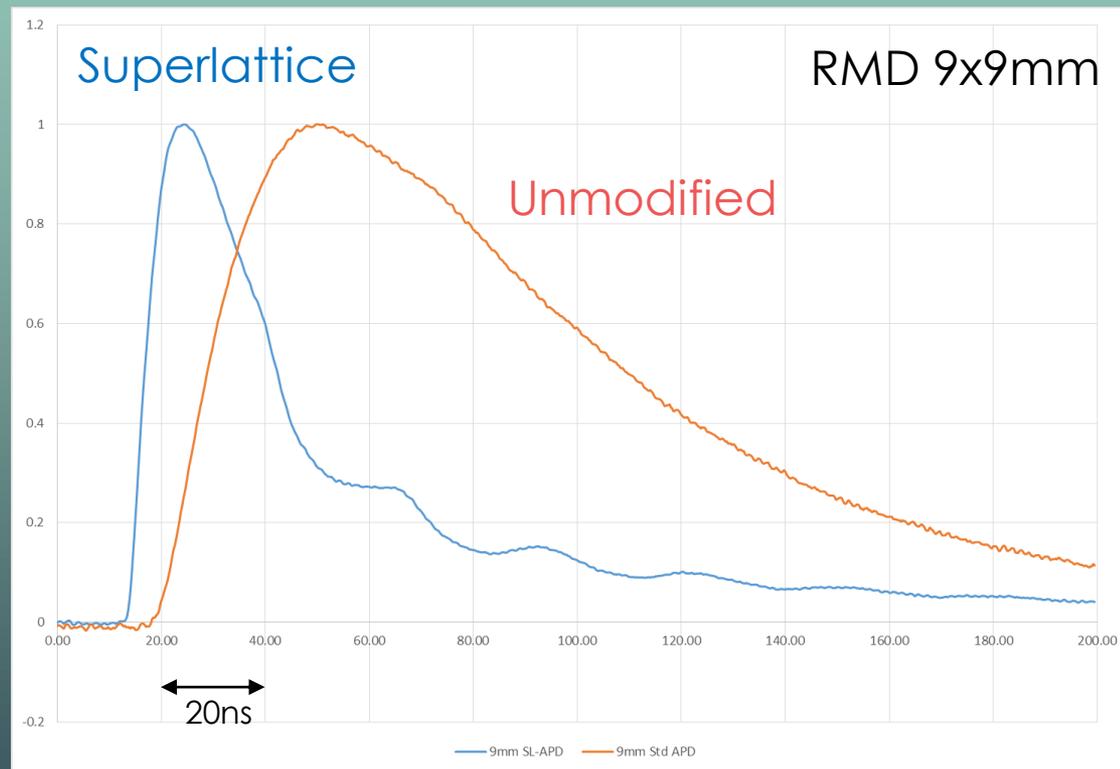


U. Arp *et al.*, *J. Elect. Spect. and Related Phenomena*, **144**, 1039 (2005)



Improved time response

- ▶ Elimination of the undepleted region before the avalanche structure improves APD time performance



M. McClish



Dark current vs. temperature

Standard RMD 9x9mm APD

BaF₂
properties

Photosensor
options

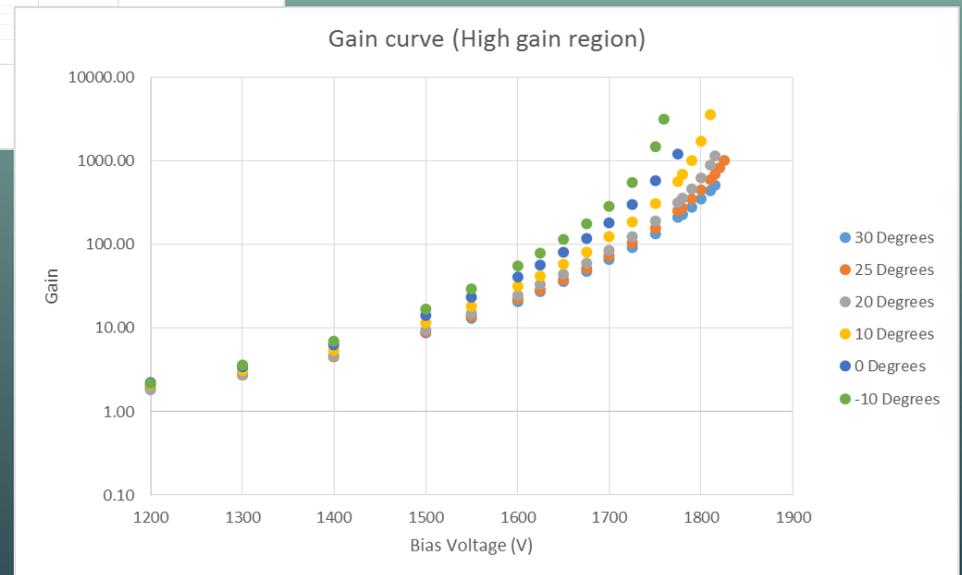
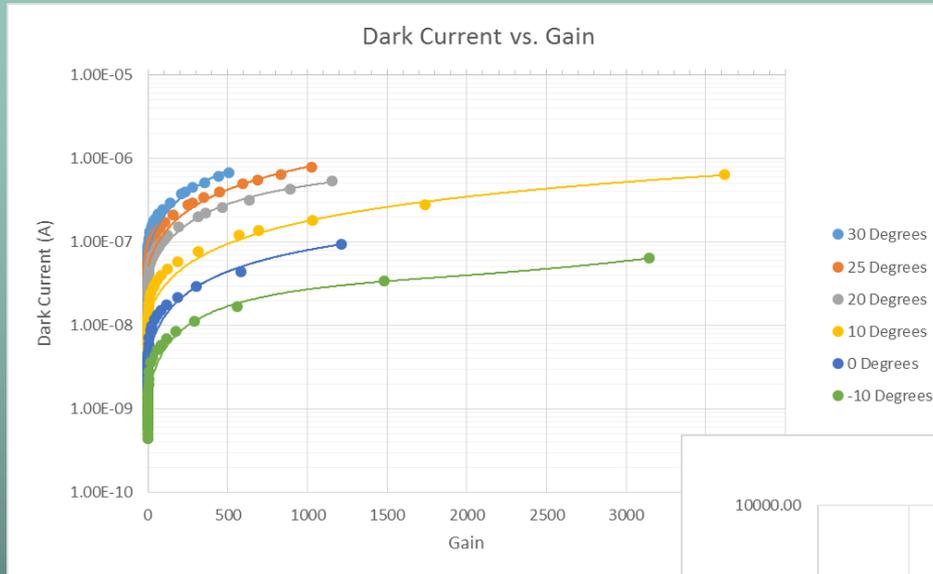
ALD filter

Superlattice

Gain, noise

Radiation
hardness

Conclusion



Dark current vs. temperature

Superlattice/5 layer ALD 9x9mm APD

BaF₂
properties

Photosensor
options

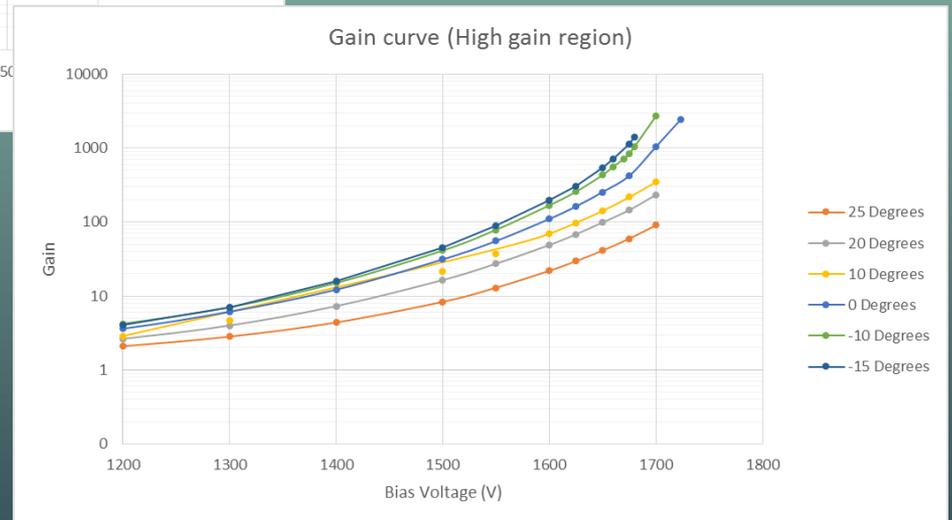
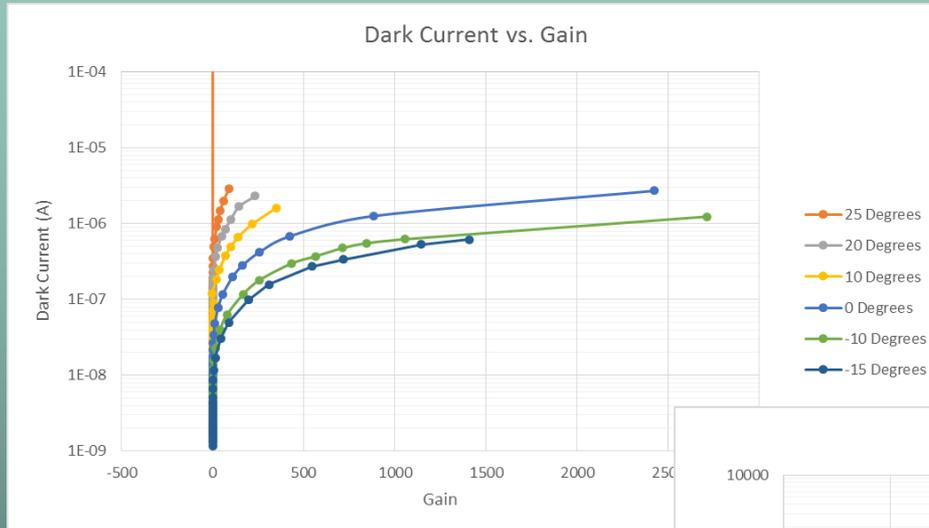
ALD filter

Superlattice

Gain, noise

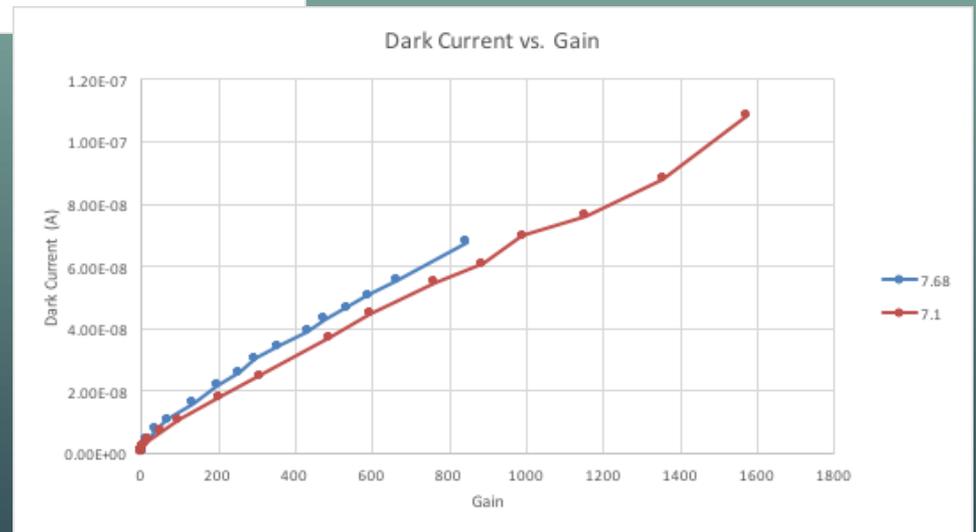
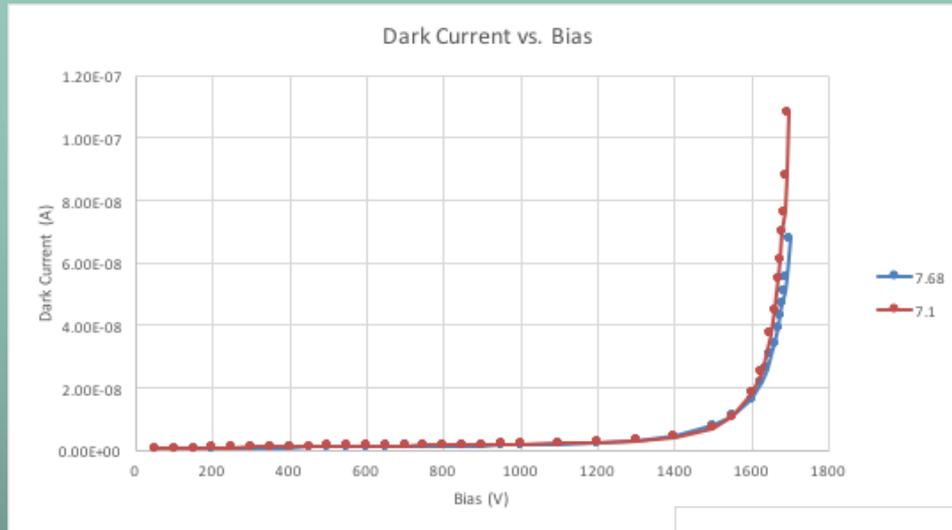
Radiation
hardness

Conclusion



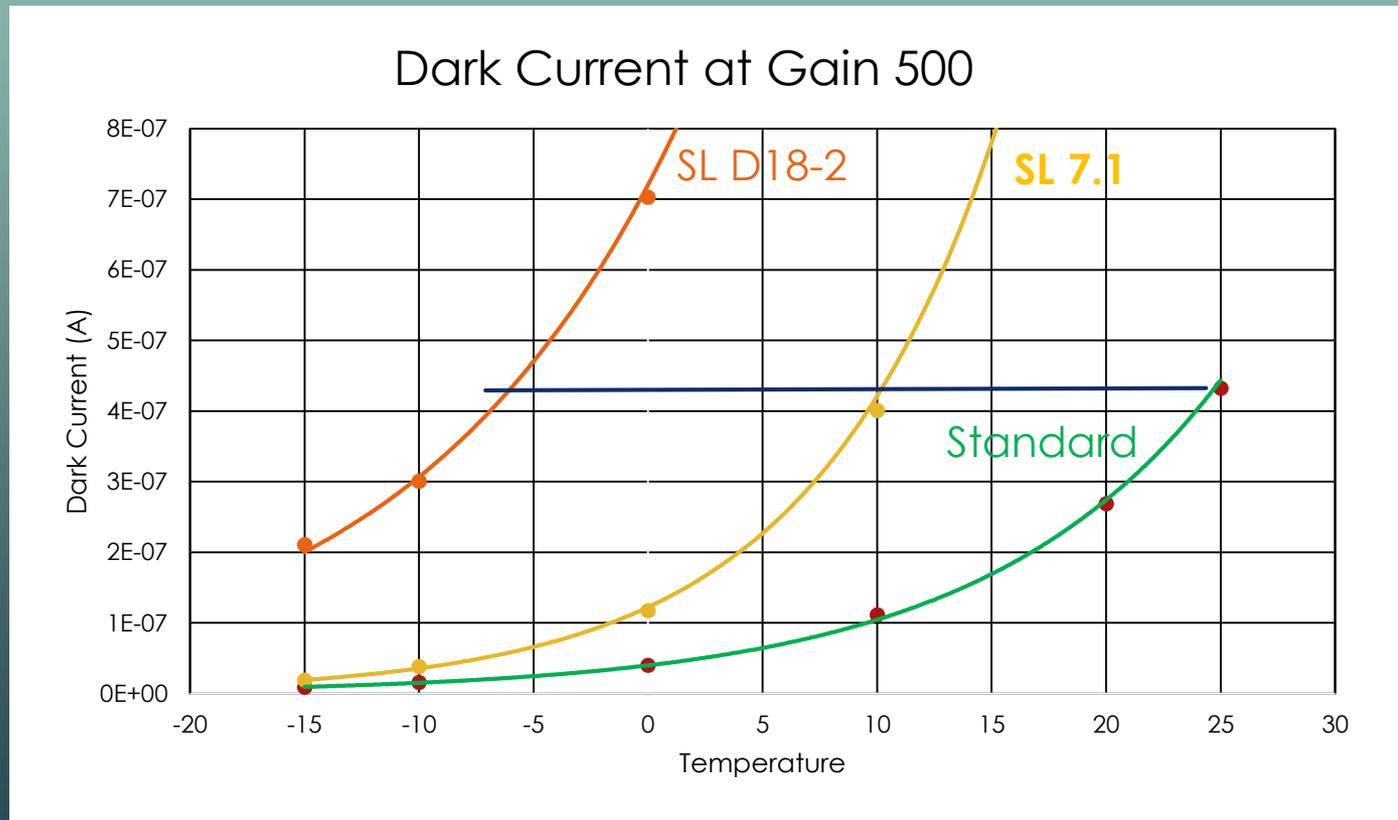
Gain/dark current at -10C

- BaF₂ properties
- Photosensor options
- ALD filter
- Superlattice
- Gain, noise
- Radiation hardness
- Conclusion



Dark current vs. temperature

- ▶ Early SL/Filter APD (D18-2) has the same dark current at -10°C as the standard device APD at room temperature
- ▶ Latest SL/filter APDs (SL 7-1 and 7.68) show substantial improvement in dark current over earlier wafers with only modest cooling: same dark current as standard device at $+10^{\circ}\text{C}$



BaF₂
properties

Photosensor
options

ALD filter

Superlattice

Gain, noise

Radiation
hardness

Conclusion



Spectra

- ▶ Taken with a small BaF₂ (1 cm³) & 9 mm SL APD

BaF₂ properties

Photosensor options

ALD filter

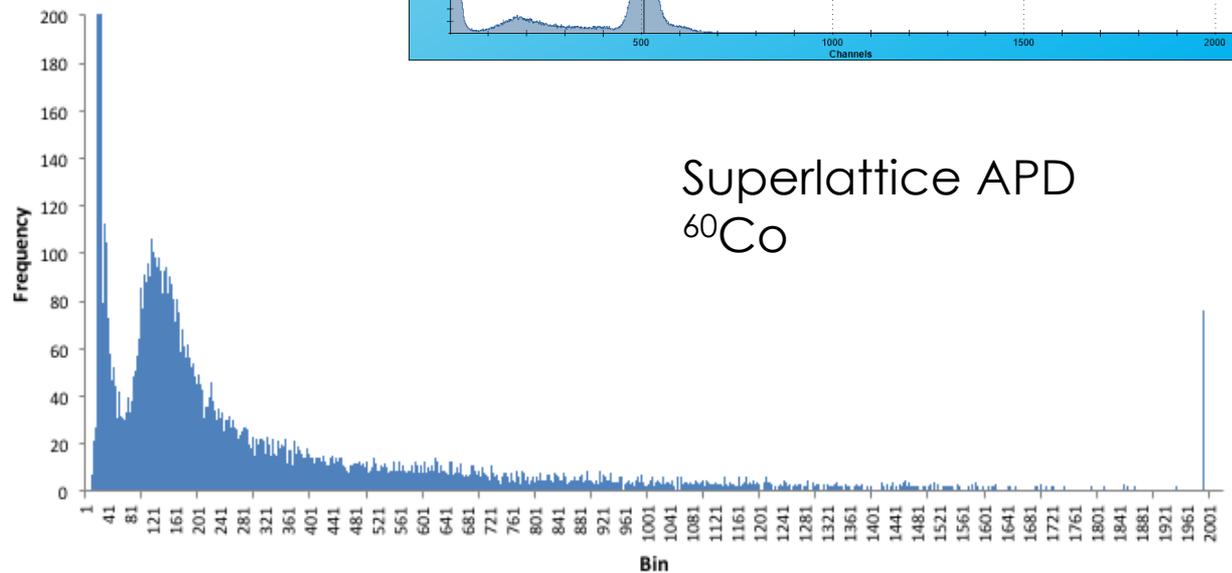
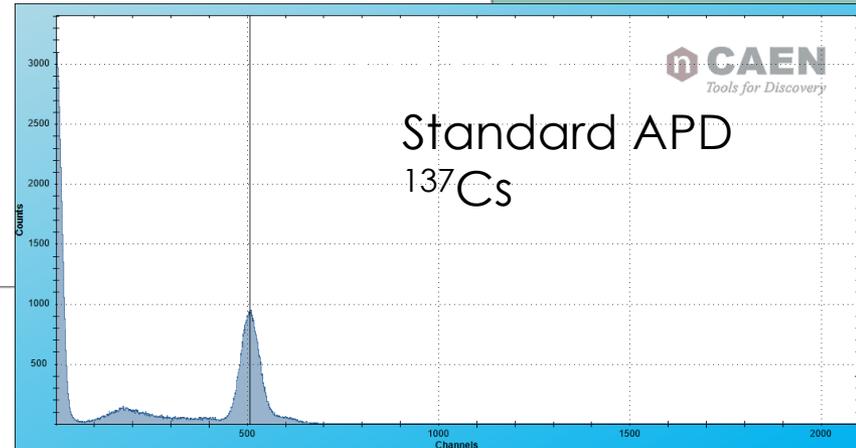
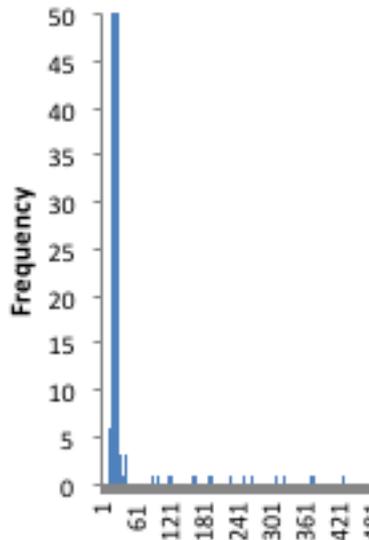
Superlattice

Gain, noise

Radiation hardness

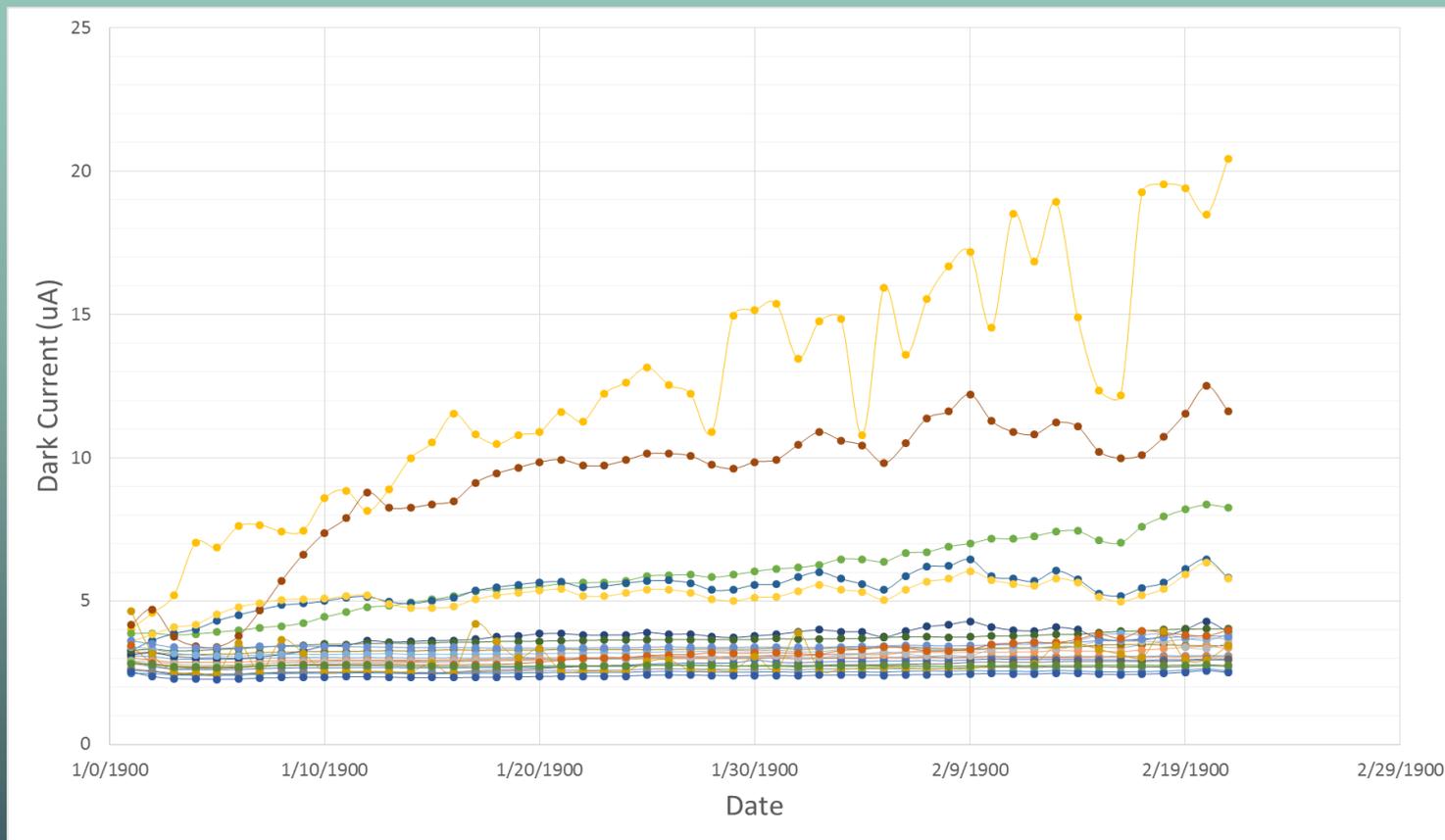
Conclusion

Background



Reliability test – 80 days

- ▶ Biased at ~1600v at 50C

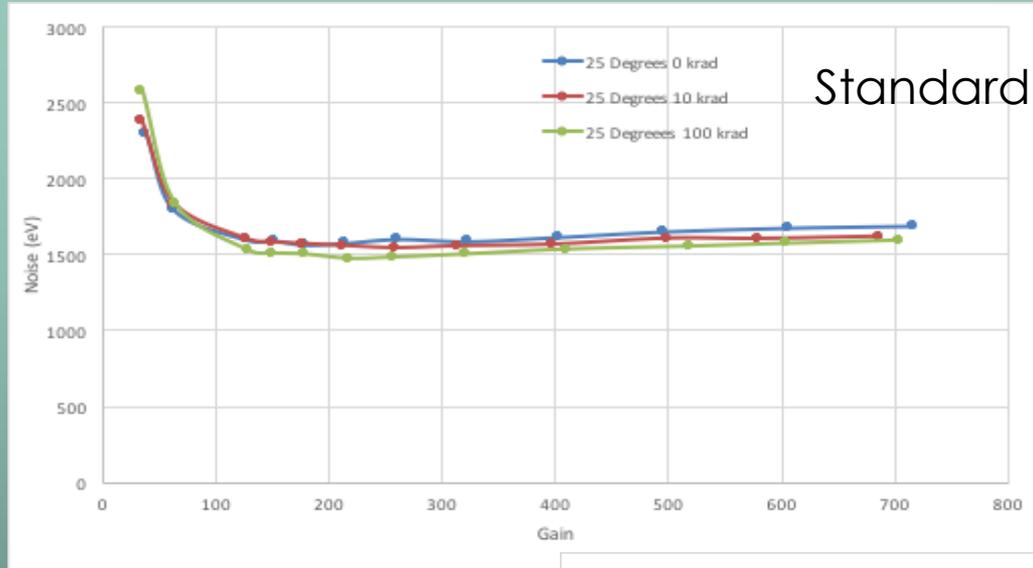


- ▶ Infant mortality: 5 of 24
- ▶ 19 devices with 0 failures implies MTF > 10^6 hours

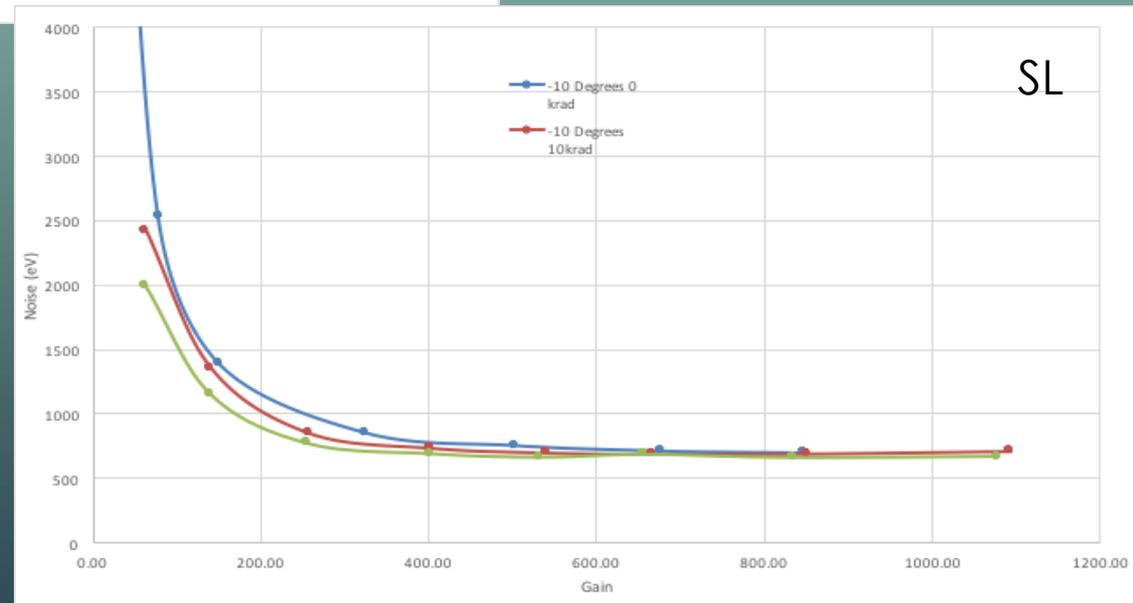


γ irradiation of standard and SL APDs

- BaF₂ properties
- Photosensor options
- ALD filter
- Superlattice
- Gain, noise
- Radiation hardness
- Conclusion



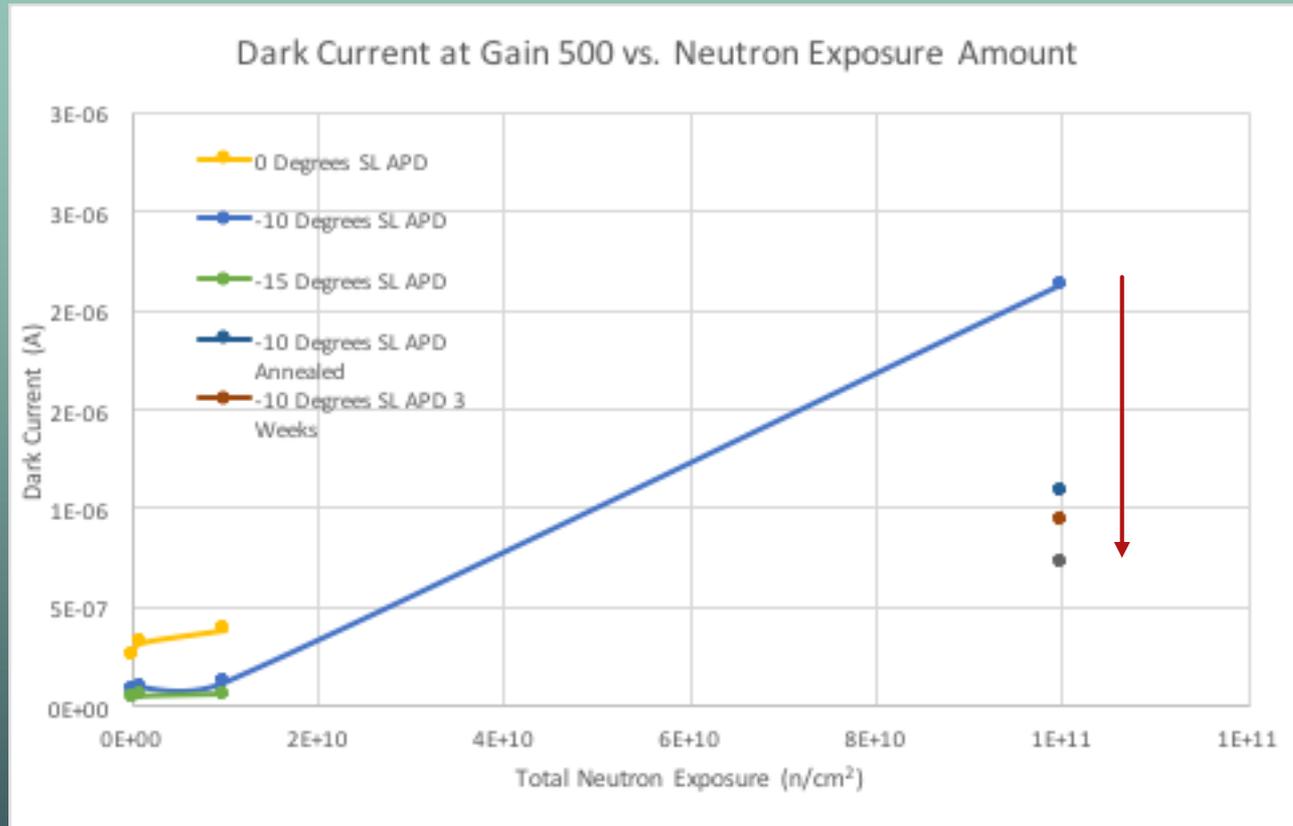
Irradiation done without bias, as we feared that unrealistic high rates could damage APDs



Neutron irradiation

▶ 14 mm superlattice APD

▶ Exposure rate is 1.4×10^5 n/cm²/s (8.2 days to 1×10^{11})



Dark current decreases after exposure due roannealing of damage



Conclusion

- We have developed an avalanche photodiode suitable for the readout of the fast component of barium fluoride scintillation light by modifying a standard RMD APD using superlattice and atomic layer deposition techniques
- Device characteristics
 - High gain (>500)
 - High QE for the 220nm BaF₂ fast component
 - Insensitive to the 300nm BaF₂ slow component
 - Excellent time performance
 - Can withstand high integrated flux of UV
 - Standard RMD APD has been shown to be radiation hard with gammas and protons
 - Irradiation tests of the SL APDs with gammas and neutrons are underway
 - Noise of initial devices is higher than that of standard devices
 - Operation at 10°C provides noise performance similar to that of standard RMD APD at room temperature

BaF₂
properties

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